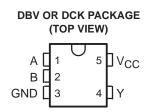
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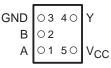
- Available in the Texas Instruments NanoStar<sup>™</sup> and NanoFree<sup>™</sup> Packages
- Low Static-Power Consumption; I<sub>CC</sub> = 0.9 μA Max
- Low Dynamic-Power Consumption; C<sub>pd</sub> = 4.3 pF Typ at 3.3 V
- Low Input Capacitance; C<sub>i</sub> = 1.5 pF Typ
- Low Noise Overshoot and Undershoot <10% of V<sub>CC</sub>
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Schmitt-Trigger Action Allows Slow Input Transition and Better Switching Noise Immunity at the Input

(V<sub>hys</sub> = 250 mV Typ at 3.3 V)



- Wide Operating V<sub>CC</sub> Range of 0.8 V to 3.6 V
- Optimized for 3.3-V Operation
- 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- t<sub>pd</sub> = 4.3 ns Max at 3.3 V
- Suitable for Point-to-Point Applications
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  2000-V Human-Body Model
  - (A114-B, Class II) – 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)
- ESD Protection Exceeds ±5000 V With Human-Body Model

YEP OR YZP PACKAGE (BOTTOM VIEW)



### description/ordering information

The AUP family is TI's premier solution to the industry's low-power needs in battery-powered portable applications. This family ensures a very low static- and dynamic-power consumption across the entire  $V_{CC}$  range of 0.8 V to 3.6 V, resulting in increased battery life (see Figure 1). This product also maintains excellent signal integrity (see the very low undershoot and overshoot characteristics shown in Figure 2).

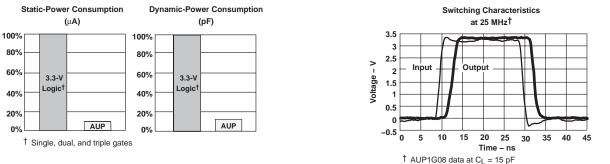


Figure 1. AUP – The Lowest-Power Family



This single 2-input positive-AND gate performs the Boolean function  $Y = A \bullet B$  or  $Y = \overline{A + B}$  in positive logic.

NanoStar<sup>™</sup> and NanoFree<sup>™</sup> package technology is a major breakthrough in IC packaging concepts, using the die as the package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

NanoStar and NanoFree are trademarks of Texas Instruments.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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SCES502B - NOVEMBER 2003 - REVISED AUGUST 2004

### description/ordering information (continued)

This device is fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

ORDER	ING INI	FORMA	TION
		•••••	

TA	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING <sup>‡</sup>
	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP	Tape and reel	SN74AUP1G08YEPR	
–40°C to 85°C	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)	Tape and reel	SN74AUP1G08YZPR	HE_
	SOT (SOT-23) – DBV	Tape and reel	SN74AUP1G08DBVR	H08_
	SOT (SC-70) – DCK	Tape and reel	SN74AUP1G08DCKR	HE_

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

<sup>‡</sup>DBV/DCK: The actual top-side marking has one additional character that designates the assembly/test site.

YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition  $(1 = SnPb, \bullet = Pb-free).$ 

FUNCTION TABLE					
INP	UTS	OUTPUT			
Α	В	Y			
L	L	L			
L	Н	L			
Н	L	L			
Н	Н	Н			

### logic diagram (positive logic)





SCES502B - NOVEMBER 2003 - REVISED AUGUST 2004

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, $V_{CC}$ Input voltage range, $V_I$ (see Note 1) Voltage range applied to any output in the high-impedance or power-off state, $V_O$	
(see Note 1)	–0.5 V to 4.6 V
Output voltage range in the high or low state, V <sub>O</sub> (see Note 1)	-0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Continuous output current, I <sub>O</sub>	±20 mA
Continuous current through V <sub>CC</sub> or GND	±50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2): DBV package	206°C/W
DCK package	252°C/W
YEP/YZP package	132°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed. 2. The package thermal impedance is calculated in accordance with JESD 51-7.

# recommended operating conditions (see Note 3)

			MIN	MAX	UNIT
VCC	Supply voltage		0.8	3.6	V
		V <sub>CC</sub> = 0.8 V	V <sub>CC</sub>		
.,		V <sub>CC</sub> = 1.1 V to 1.95 V	$0.65 \times V_{CC}$		
VIH	High-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V	1.6		V
		$V_{CC} = 3 \vee to 3.6 \vee$	2		
		V <sub>CC</sub> = 0.8 V		0	
	Land Land Constant to the sec	V <sub>CC</sub> = 1.1 V to 1.95 V		$0.35 \times V_{CC}$	
VIL	Low-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V		0.7	V
		$V_{CC} = 3 V \text{ to } 3.6 V$		0.9	
VI	Input voltage		0	3.6	V
VO	Output voltage		0	VCC	V
		V <sub>CC</sub> = 0.8 V		-20	μA
		V <sub>CC</sub> = 1.1 V		-1.1	
	Liber Incole and a company	$V_{CC} = 1.4 V$		-1.7	
ЮН	High-level output current	$V_{CC} = 1.65$		-1.9	mA
		V <sub>CC</sub> = 2.3 V		-3.1	
		$V_{CC} = 3 V$		-4	
		V <sub>CC</sub> = 0.8 V		20	μΑ
		V <sub>CC</sub> = 1.1 V		1.1	
1		$V_{CC} = 1.4 V$		1.7	
IOL	Low-level output current	V <sub>CC</sub> = 1.65 V		1.9	mA
		V <sub>CC</sub> = 2.3 V		3.1	
		V <sub>CC</sub> = 3 V		4	
$\Delta t/\Delta v$	Input transition rise or fall rate	$V_{CC}$ = 0.8 V to 3.6 V		200	ns/V
TA	Operating free-air temperature		-40	85	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



SCES502B – NOVEMBER 2003 – REVISED AUGUST 2004

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

				T,	A = 25°C	;	T <sub>A</sub> = −40°C	C TO 85°C		
PARAMETER	TEST CONDITIONS		VCC	MIN	TYP	MAX	MIN	MAX	UNIT	
	I <sub>OH</sub> = -20 μA		0.8 V to 3.6 V	V <sub>CC</sub> – 0.1			V <sub>CC</sub> – 0.1			
	I <sub>OH</sub> = -1.1 mA		1.1 V	$0.75 \times V_{CC}$			$0.7 \times V_{CC}$			
	I <sub>OH</sub> = -1.7 mA		1.4 V	1.11			1.03			
	I <sub>OH</sub> = -1.9 mA		1.65 V	1.32			1.3			
VOH	I <sub>OH</sub> = -2.3 mA			2.05			1.97		V	
	I <sub>OH</sub> = -3.1 mA		2.3 V	1.9			1.85			
	I <sub>OH</sub> = -2.7 mA		0.1/	2.72			2.67			
	$I_{OH} = -4 \text{ mA}$		3 V	2.6			2.55			
	I <sub>OL</sub> = 20 μA		0.8 V to 3.6 V			0.1		0.1		
	I <sub>OL</sub> = 1.1 mA		1.1 V			$0.3 \times V_{CC}$		$0.3 \times V_{CC}$		
	I <sub>OL</sub> = 1.7 mA		1.4 V			0.31		0.37		
	I <sub>OL</sub> = 1.9 mA		1.65 V		0.31		0.35			
V <sub>OL</sub>	I <sub>OL</sub> = 2.3 mA					0.31		0.33	V	
	I <sub>OL</sub> = 3.1 mA		2.3 V			0.44		0.45		
	I <sub>OL</sub> = 2.7 mA		2.1/			0.31		0.33		
	$I_{OL} = 4 \text{ mA}$		3 V			0.44		0.45		
I A or B input	$V_I = GND$ to 3.6 V		0 V to 3.6 V			0.1		0.5	μA	
loff	$V_{I}$ or $V_{O} = 0 V$ to 3.6	V	0 V			0.2		0.6	μA	
$\Delta I_{\text{off}}$	$V_{I}$ or $V_{O} = 0 V$ to 3.6	V	0 V to 0.2 V			0.2		0.6	μA	
ICC	V <sub>I</sub> = GND or (V <sub>CC</sub> to 3.6 V)	I <sup>O</sup> = 0	0.8 V to 3.6 V			0.5		0.9	μΑ	
ΔICC	$V_{I} = V_{CC} - 0.6 V^{\dagger}$	IO = 0	3.3 V			40		50	μA	
		-	0 V		1.5				_	
Ci	$V_{I} = V_{CC} \text{ or } GND$		3.6 V		1.5				pF	
Co	V <sub>O</sub> = GND		0 V		3				pF	

<sup>+</sup> One input at V<sub>CC</sub> – 0.6 V, other input at V<sub>CC</sub> or GND

switching characteristics over recommended operating free-air temperature range,  $C_L = 5 \text{ pF}$  (unless otherwise noted) (see Figures 3 and 4)

PARAMETER	FROM	TO	Vcc	т,	ק = 25°C	;	T <sub>A</sub> = - TO 8		UNIT
	(INPUT)	(OUTPUT)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		18				
			$1.2 \text{ V} \pm 0.1 \text{ V}$	2.6	7.3	12.8	2.1	15.6	
· .	A or D	X	$1.5~V\pm0.1~V$	1.4	5.2	8.7	0.9	10.3	
<sup>t</sup> pd	A or B	Y	$1.8~V\pm0.15~V$	1	4.2	6.6	0.5	8.2	ns
			$2.5~\text{V}\pm0.2~\text{V}$	1	3	4.4	0.5	5.5	
			$3.3~\text{V}\pm0.3~\text{V}$	1	2.4	3.5	0.5	4.3	



SCES502B - NOVEMBER 2003 - REVISED AUGUST 2004

# switching characteristics over recommended operating free-air temperature range, $C_L = 10 \text{ pF}$ (unless otherwise noted) (see Figures 3 and 4)

PARAMETER	FROM	TO	Vee		ק = 25°C	;	T <sub>A</sub> = - TO 8		UNIT
	(INPUT)	(OUTPUT)	JOIPOI)	MIN	TYP	MAX	MIN	MAX	
			0.8 V		21				
			1.2 V ± 0.1 V	1.5	8.5	14.7	1	17.2	
<b>.</b>	A		$1.5 \text{ V} \pm 0.1 \text{ V}$	1	6.2	10	0.5	11.3	
<sup>t</sup> pd	A or B	Y	1.8 V ± 0.15 V	1	5	7.7	0.5	9	ns
			$2.5~\text{V}\pm0.2~\text{V}$	1	3.6	5.2	0.5	6.1	
			$3.3~\text{V}\pm0.3~\text{V}$	1	2.9	4.2	0.5	4.7	

# switching characteristics over recommended operating free-air temperature range, $C_L = 15 \text{ pF}$ (unless otherwise noted) (see Figures 3 and 4)

PARAMETER	FROM	Vcc		;	T <sub>A</sub> = - TO 8	UNIT			
	(INPUT)	(OUTPUT)	001201)	MIN	TYP	MAX	MIN	MAX	
			0.8 V		24				
			$1.2~V\pm0.1~V$	3.6	9.9	16.3	3.1	19.9	
÷ .	A as D	X	$1.5~V\pm0.1~V$	2.3	7.2	11.1	1.8	13.2	
<sup>t</sup> pd	A or B	Y	1.8 V ± 0.15 V	1.6	5.8	8.7	1.1	10.6	ns
		$2.5~\text{V}\pm0.2~\text{V}$	1	4.3	5.9	0.5	7.3		
			$3.3~\text{V}\pm0.3~\text{V}$	1	3.4	4.8	0.5	5.9	

# switching characteristics over recommended operating free-air temperature range, $C_L = 30 \text{ pF}$ (unless otherwise noted) (see Figures 3 and 4)

PARAMETER	FROM	TO	V <sub>CC</sub>		ק = 25°C	;	T <sub>A</sub> = - TO 8		UNIT
	(INPUT)	(OUTPUT)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		32.8				
			$1.2 \text{ V} \pm 0.1 \text{ V}$	4.9	13.1	20.9	4.4	25.5	
+ .	A or B	X	$1.5~\text{V}\pm0.1~\text{V}$	3.4	9.5	14.2	2.9	16.9	
<sup>t</sup> pd	AOIB	Y	$1.8~\text{V}\pm0.15~\text{V}$	2.5	7.7	11	2	13.5	ns
			$2.5~\text{V}\pm0.2~\text{V}$	1.8	5.7	7.6	1.3	9.4	
			$3.3~\text{V}\pm0.3~\text{V}$	1.5	4.7	6.2	1	7.5	

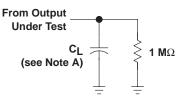
# operating characteristics, $T_A$ = 25°C

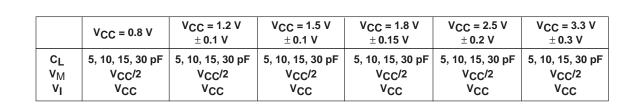
	PARAMETER	TEST CONDITIONS	Vcc	TYP	UNIT
			0.8 V	4	
		$1.2~V\pm0.1~V$	4		
		f = 10 MHz	1.5 V ± 0.1 V	4	~ <b>F</b>
C <sub>pd</sub>	Power dissipation capacitance		$1.8~V\pm0.15~V$	4	pF
			$2.5~\text{V}\pm0.2~\text{V}$	4.1	
			$3.3~\text{V}\pm0.3~\text{V}$	4.3	



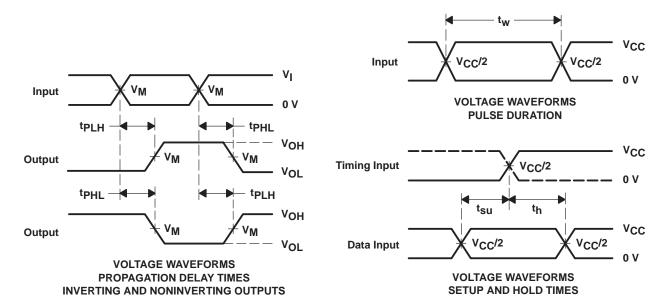
SCES502B - NOVEMBER 2003 - REVISED AUGUST 2004

### PARAMETER MEASUREMENT INFORMATION (Propagation Delays, Setup and Hold Times, and Pulse Duration)





LOAD CIRCUIT



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

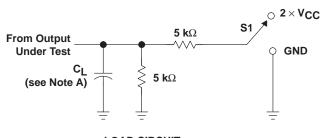
- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , slew rate  $\geq$  1 V/ns.
- C. The outputs are measured one at a time, with one transition per measurement.
- D.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- E. All parameters and waveforms are not applicable to all devices.

#### Figure 3. Load Circuit and Voltage Waveforms



SCES502B - NOVEMBER 2003 - REVISED AUGUST 2004

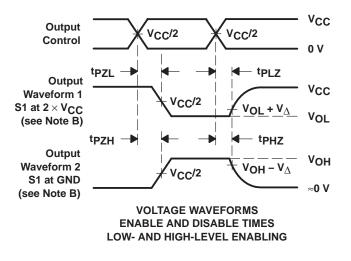
### PARAMETER MEASUREMENT INFORMATION (Enable and Disable Times)



TEST	S1
<sup>t</sup> PLZ <sup>/t</sup> PZL	$2 \times V_{CC}$
<sup>t</sup> PHZ <sup>/t</sup> PZH	GND

LOAD	CIRCUIT	

	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub> = 1.2 V ± 0.1 V	V <sub>CC</sub> = 1.5 V ± 0.1 V	V <sub>CC</sub> = 1.8 V ± 0.15 V	V <sub>CC</sub> = 2.5 V ± 0.2 V	V <sub>CC</sub> = 3.3 V ± 0.3 V
CL	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
VM	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2
VI	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>
V <sub>A</sub>	0.1 V	0.1 V	0.1 V	0.15 V	0.15 V	0.3 V



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , slew rate  $\geq$  1 V/ns. D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. tpzL and tpzH are the same as  $t_{en}$ .
- G. All parameters and waveforms are not applicable to all devices.

### Figure 4. Load Circuit and Voltage Waveforms



### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74AUP1G08DBVR	ACTIVE	SOT-23	DBV	5	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G08DBVT	ACTIVE	SOT-23	DBV	5	250	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G08DCKR	ACTIVE	SC70	DCK	5	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G08DCKT	ACTIVE	SC70	DCK	5	250	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G08YEPR	ACTIVE	WCSP	YEP	5	3000	None	SNPB	Level-1-260C-UNLIM
SN74AUP1G08YZPR	ACTIVE	WCSP	YZP	5	3000	Pb-Free (RoHS)	SNAGCU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

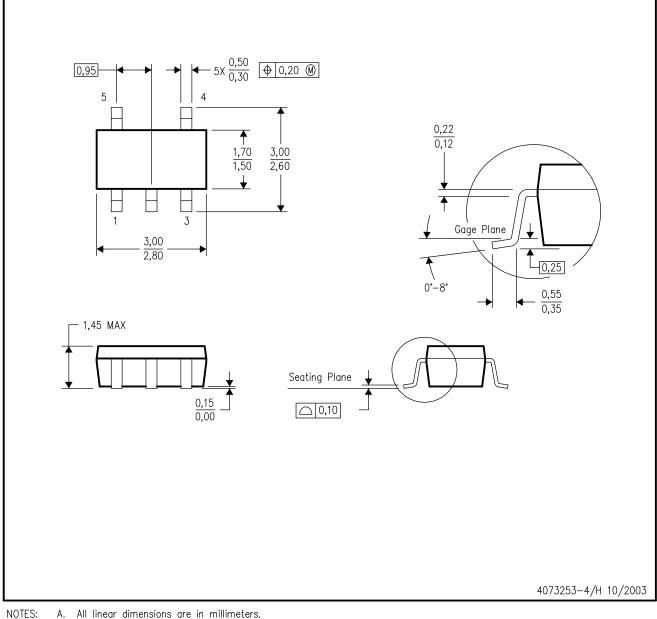
<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



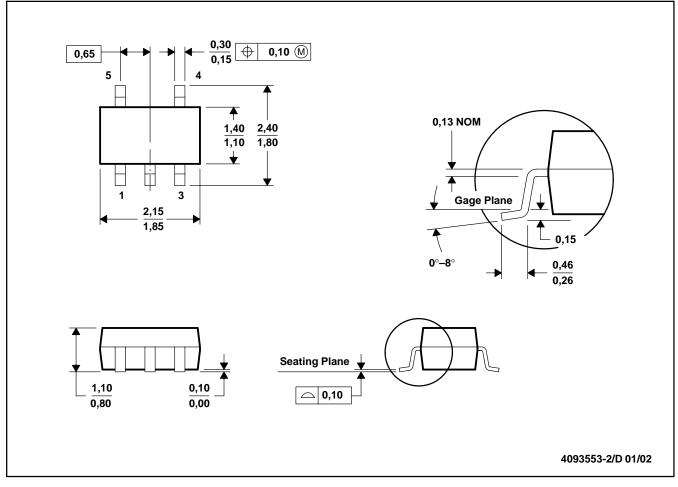
- Α. All linear dimensions are in millimeters.
  - Β. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold fla D. Falls within JEDEC MO-178 Variation AA. Body dimensions do not include mold flash or protrusion.



MPDS025C - FEBRUARY 1997 - REVISED FEBRUARY 2002

### DCK (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



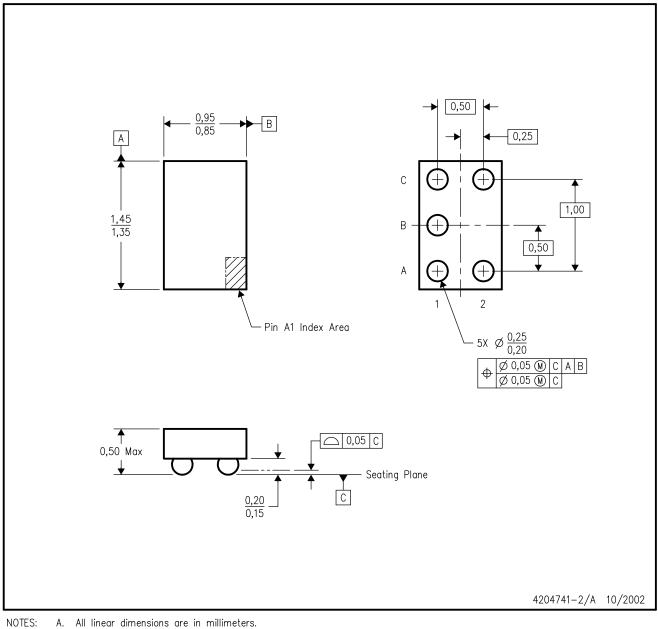
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion.
- D. Falls within JEDEC MO-203



YZP (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



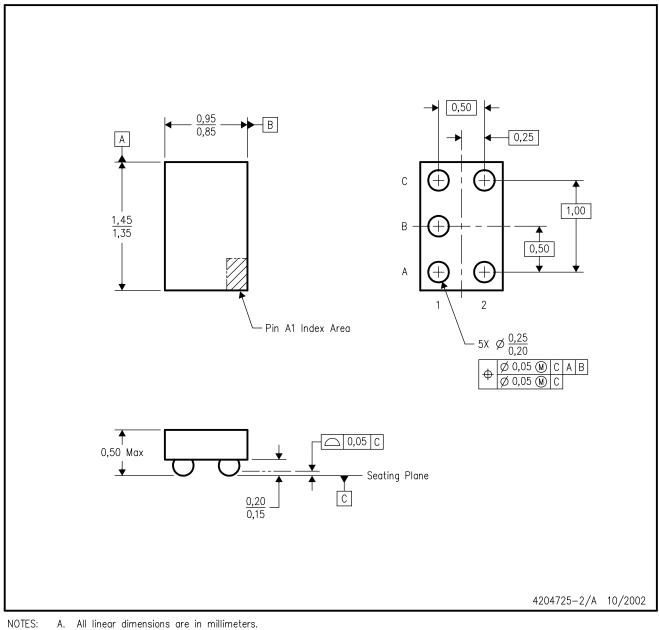
- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- D. This package is lead-free. Refer to the 5 YEP package (drawing 4204725) for tin-lead (SnPb).

NanoFree is a trademark of Texas Instruments.



YEP (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



- B. This drawing is subject to change without notice.
- C. NanoStar™ package configuration.
- D. This package is tin-lead (SnPb). Refer to the 5 YZP package (drawing 4204741) for lead-free.

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